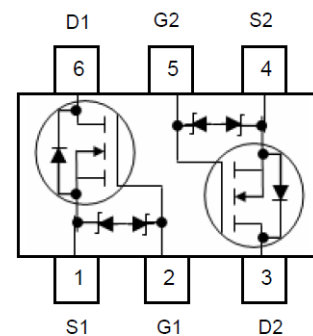
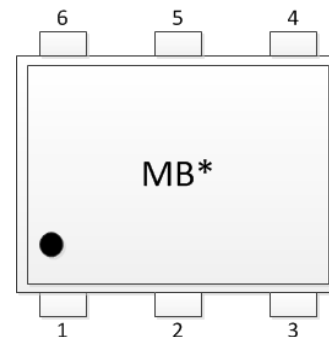


**WNMD2090**
**Dual N-Channel, 20V, 0.62A, Power MOSFET**
[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

$V_{DS}$ (V)	$R_{ds(on)}$ ( $\Omega$ )
20	0.420 @ $V_{GS}=4.5V$
	0.580 @ $V_{GS}=2.5V$
	0.800 @ $V_{GS}=1.8V$
ESD Protected	


**PDFN2X2-6L**

**Pin configuration (Top view)**


MB = Device Code  
 \* = Month (A~Z)

**Marking**
**Order information**

Device	Package	Shipping
WNMD2090-6/TR	PDFN2X2-6L	3000 /Reel&Tape

**Descriptions**

The WNMD2090 is Dual N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNMD2090 is Pb-free and Halogen-free.

**Features**

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package PDFN2X2-6L

**Applications**

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

**Absolute Maximum ratings**

Parameter	Symbol	10 s	Steady State	Unit	
Drain-Source Voltage	$V_{DS}$	20		V	
Gate-Source Voltage	$V_{GS}$	$\pm 10$			
Continuous Drain Current <sup>a d</sup>	$I_D$	$T_A=25^\circ\text{C}$	0.62	0.57	A
		$T_A=70^\circ\text{C}$	0.50	0.45	
Maximum Power Dissipation <sup>a d</sup>	$P_D$	$T_A=25^\circ\text{C}$	0.35	0.29	W
		$T_A=70^\circ\text{C}$	0.22	0.19	
Continuous Drain Current <sup>b d</sup>	$I_D$	$T_A=25^\circ\text{C}$	0.53	0.49	A
		$T_A=70^\circ\text{C}$	0.43	0.39	
Maximum Power Dissipation <sup>b d</sup>	$P_D$	$T_A=25^\circ\text{C}$	0.26	0.22	W
		$T_A=70^\circ\text{C}$	0.16	0.14	
Pulsed Drain Current <sup>c</sup>	$I_{DM}$	1.0		A	
Operating Junction Temperature	$T_J$	-55 to 150		$^\circ\text{C}$	
Lead Temperature	$T_L$	260		$^\circ\text{C}$	
Storage Temperature Range	$T_{stg}$	-55 to 150		$^\circ\text{C}$	

**Thermal resistance ratings**

Parameter	Symbol	Typical	Maximum	Unit	
Junction-to-Ambient Thermal Resistance <sup>a</sup>	$R_{\theta JA}$	$t \leq 10 \text{ s}$	310	360	$^\circ\text{C/W}$
		Steady State	366	432	
Junction-to-Ambient Thermal Resistance <sup>b</sup>	$R_{\theta JA}$	$t \leq 10 \text{ s}$	415	486	
		Steady State	498	575	
Junction-to-Case Thermal Resistance	$R_{\theta JC}$	265	305		

a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper

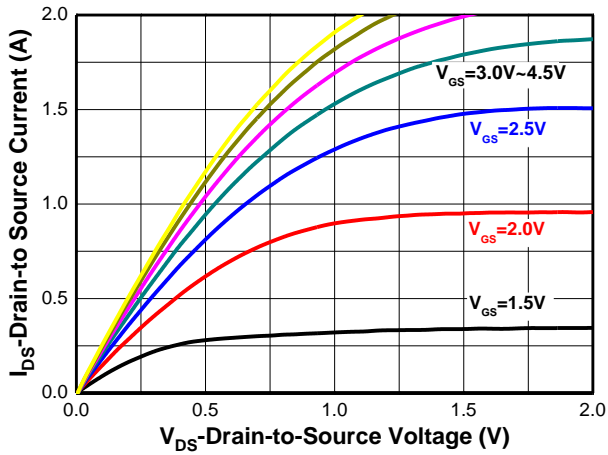
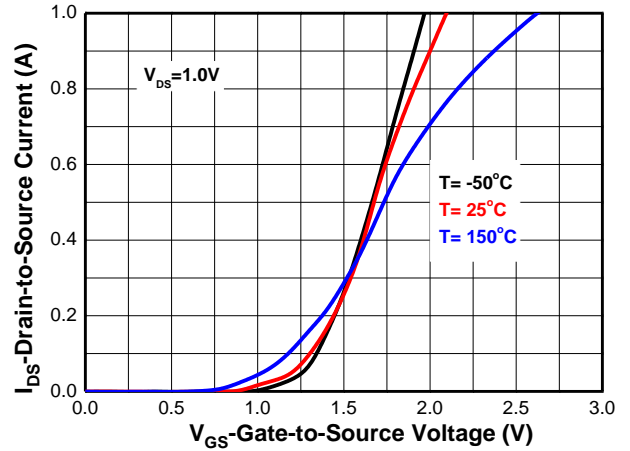
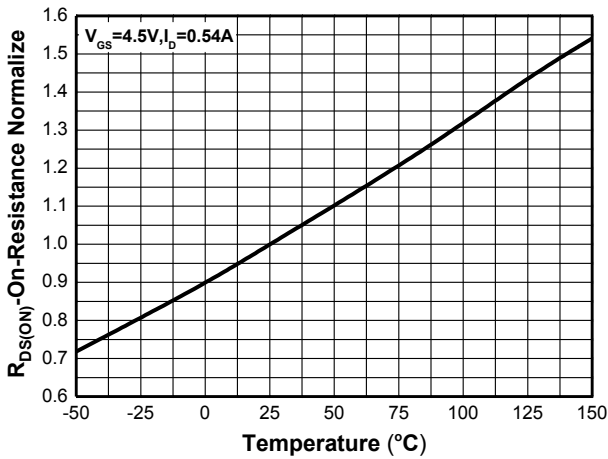
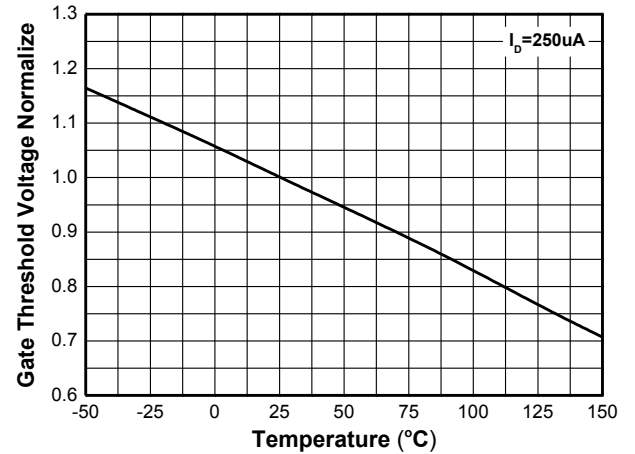
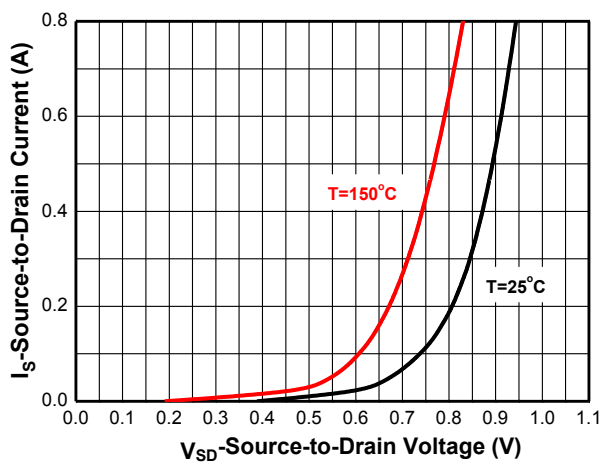
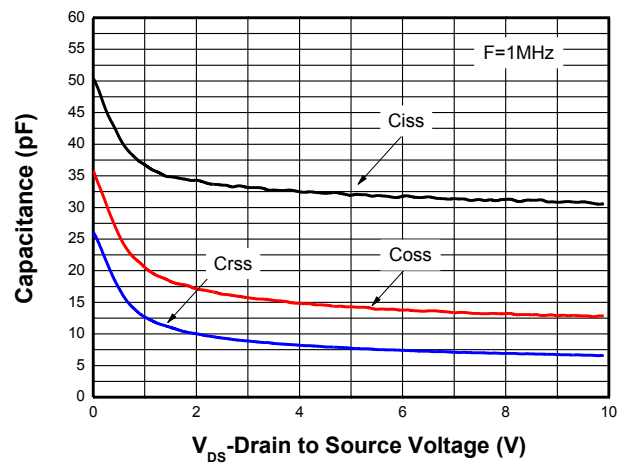
b Surface mounted on FR-4 board using minimum pad size, 1oz copper

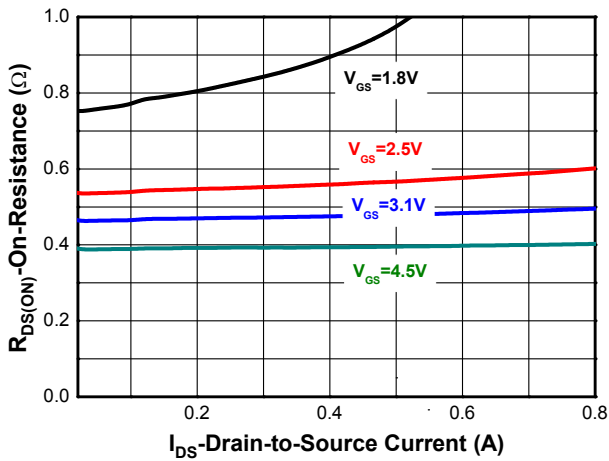
c Pulse width < 380 $\mu\text{s}$ , Duty Cycle < 2%

d Maximum junction temperature  $T_J=150^\circ\text{C}$ .

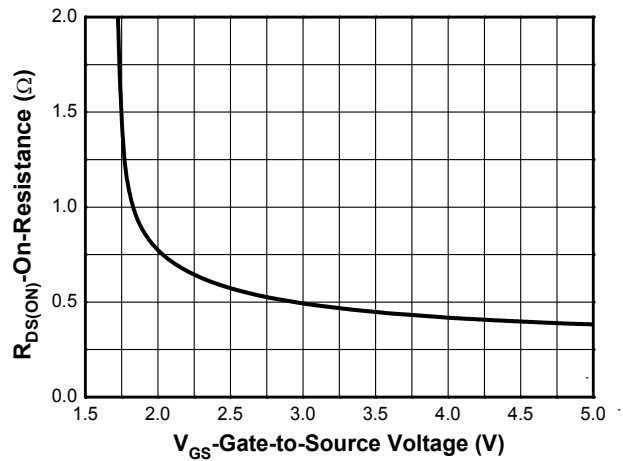
**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\mu\text{A}$	20			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 16\text{V}, V_{GS} = 0\text{V}$			1	$\mu\text{A}$
Gate-to-source Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 10\text{V}$			$\pm 5$	$\mu\text{A}$
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	0.45	0.70	1.0	V
Forward Transconductance <sup>e</sup>	$g_{FS}$	$V_{DS} = 10\text{V}, I_D = 0.35\text{A}$		0.85		S
Drain-to-source On-resistance <sup>b, c</sup>	$R_{DS(on)}$	$V_{GS} = 4.5\text{V}, I_D = 0.50\text{A}$		380	600	m $\Omega$
		$V_{GS} = 3.1\text{V}, I_D = 0.30\text{A}$		460	700	
		$V_{GS} = 2.5\text{V}, I_D = 0.30\text{A}$		530	800	
		$V_{GS} = 1.8\text{V}, I_D = 0.10\text{A}$		700	1300	
		$V_{GS} = 1.5\text{V}, I_D = 0.04\text{A}$		900	1600	
<b>CAPACITANCES, CHARGES</b>						
Input Capacitance	$C_{ISS}$	$V_{GS} = 0\text{ V},$		30		pF
Output Capacitance	$C_{OSS}$	$f = 1\text{MHz},$		12.8		
Reverse Transfer Capacitance	$C_{RSS}$	$V_{DS} = 10\text{ V}$		6		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 4.5\text{ V},$ $V_{DS} = 10\text{ V},$ $I_D = 0.54\text{A}$		1.07		nC
Threshold Gate Charge	$Q_{G(TH)}$			0.12		
Gate-to-Source Charge	$Q_{GS}$			0.32		
Gate-to-Drain Charge	$Q_{GD}$			0.14		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	$t_d(ON)$	$V_{GS} = 4.5\text{ V},$ $V_{DD} = 10\text{ V},$ $I_D = 0.54\text{ A},$ $R_G = 6\ \Omega$		7.2		ns
Rise Time	$t_r$			9.5		
Turn-Off Delay Time	$t_d(OFF)$			19.6		
Fall Time	$t_f$			4.6		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	$V_{SD}$	$V_{GS} = 0\text{ V}, I_S = 0.3\text{A}$		0.85	1.5	V

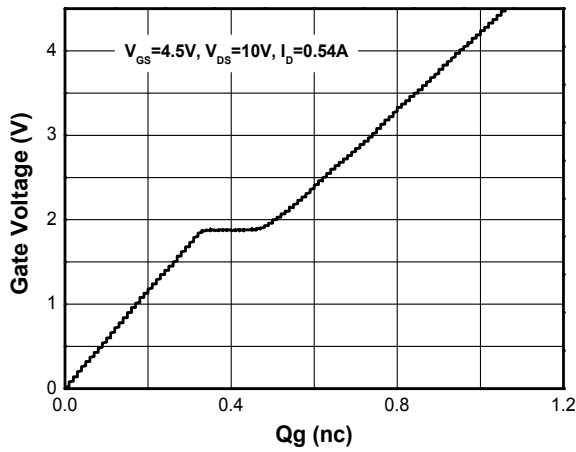
**Typical Characteristics (Ta=25°C, unless otherwise noted)**

**Output characteristics**

**Transfer characteristics**

**On-Resistance vs. Junction temperature**

**Threshold voltage vs. Temperature**

**Body diode forward voltage**

**Capacitance**



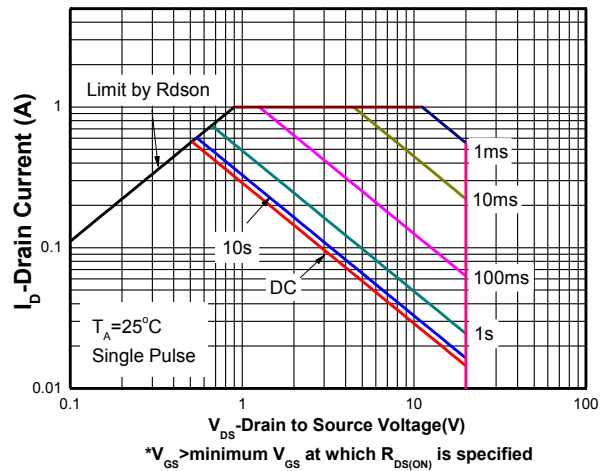
On-Resistance vs. Drain current



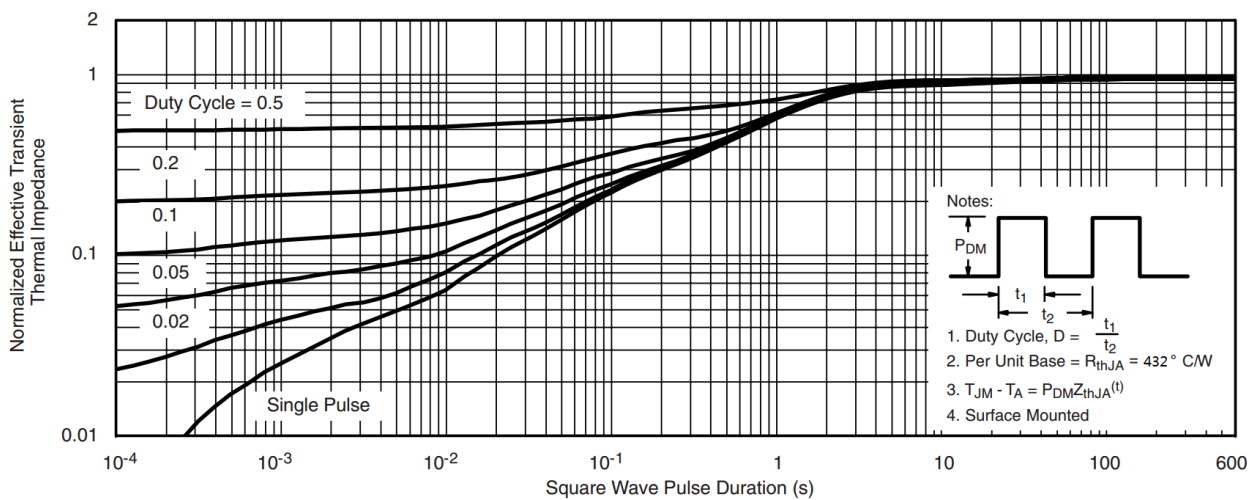
On-Resistance vs. Gate-to-Source voltage



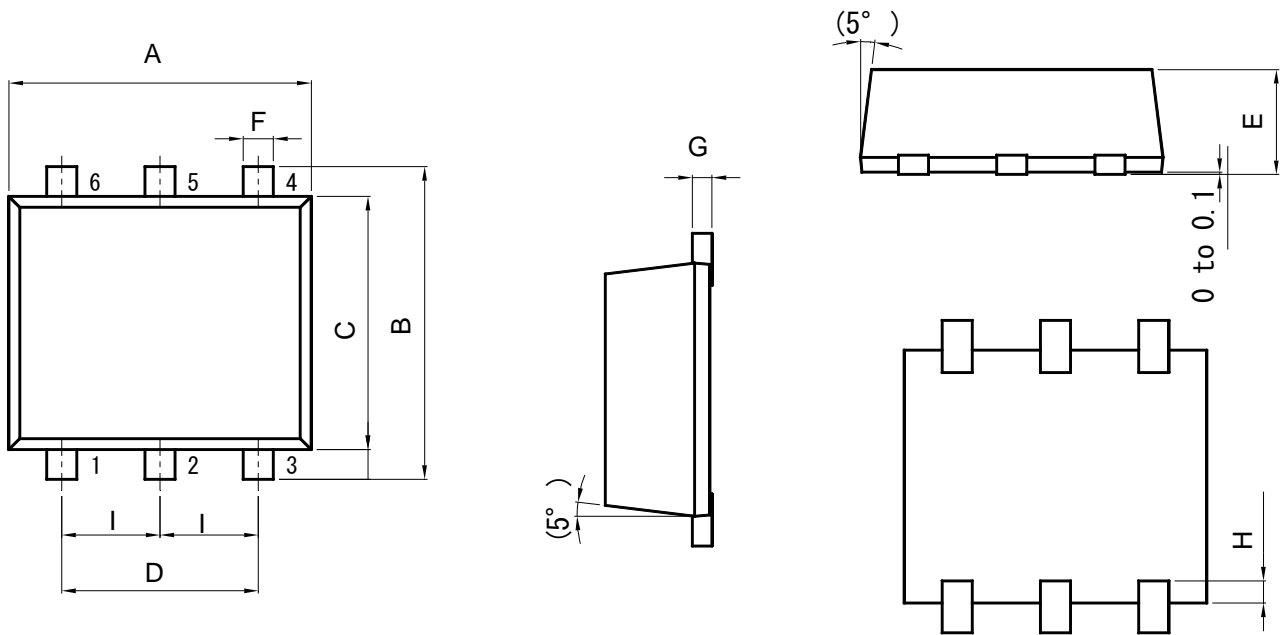
Total Gate Charge



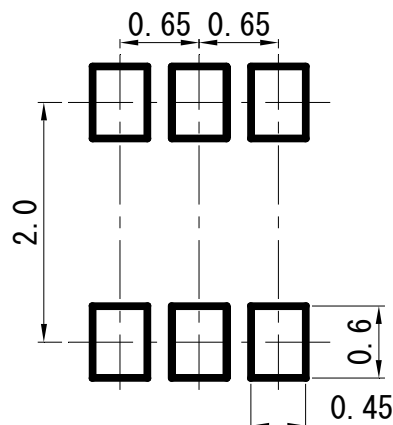
Safe operating power



Transient thermal response (Junction-to-Ambient)

**Package outline dimensions**
**PDFN2X2-6L**


Symbol	Dimension in Millimeters	
	Min.	Max.
A	1.9	2.1
B	2.0	2.2
C	1.6	1.8
D	1.2	1.4
E	0.6	0.8
F	0.18	0.25
G	0.1	0.18
H	0.15	
I	0.65	

**Land Pattern (Reference) (Unit : mm)**


*Note: This land pattern is for your reference only. Actual pad layouts may vary depending on application.*